

P26634.A02



IFW

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants : Chuen Khiang WANG et al.

Group Art Unit : Not Yet Assigned

Appl. No. : 10/598,514 (U.S. National
Stage of PCT/SG2005/00067)

Examiner : Not Yet Assigned

I.A. Filed : March 3, 2005

Confirmation No. : 6698

For : MULTIPLE STACKED DIE WINDOW CSP PACKAGE AND METHOD
OF MANUFACTURE

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
U.S. Patent and Trademark Office
Customer Service Window, Mail Stop AMENDMENT
Randolph Building
401 Dulany Street
Alexandria, VA 22314

Sir:

In accordance with the duty of disclosure under 37 C.F.R. §1.56 and §§1.97-1.98, Applicants hereby bring to the attention of the Examiner the following information.

The following documents were cited in an International Search Report with respect to International Patent Application No. PCT/ SG2005/00067, of which the present application is the U.S. National Stage Application. A copy of the International Search Report has been filed concurrently with the present application and should thus have already been brought to the attention of the Examiner.

- (1) U.S. Patent No. 6,107,109;
- (2) U.S. Patent No. 5,222,014;

- (3) U.S. Patent Application Publication No. 2002/0027295;
- (4) European Patent Publication No. EP 1 355 352, and patent family member U.S. Patent No. 6,781,241;
- (5) U.S. Patent Application Publication No. 2002/0149097;
- (6) U.S. Patent Application Publication No. 2004/0159954; and
- (7) International Publication No. WO 2004/088727.

The relevance of the documents cited in the International Search Report, as ascertained with respect to the international claims by the International Examiner, is set forth in the International Search Report.

Applicants further bring to the attention of the Examiner the following document:

- (8) U.S. Patent Application Publication No. 2003/0197284. Applicants note that this document is cited beginning at page 2 of the specification of the above-captioned application.

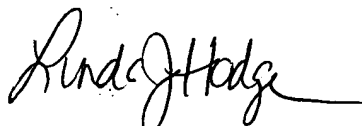
Further to 37 C.F.R. §1.98 (a)(2)(ii), copies of the U.S. patent publications are not enclosed herewith. However, if any copy is needed, the Examiner is respectfully requested to contact the undersigned.

Applicants respectfully request that the Examiner consider the above material and cite the same. Copies of the above-noted foreign and international documents are attached hereto, and all of the documents are listed on an attached PTO-1449 Form. The Examiner is requested to initial the appropriate spaces on the attached Form and to return a copy of the completed Form to Applicants with the next official communication in the present application.

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Should the Examiner have any questions, the Examiner is invited to contact the undersigned at the below-listed telephone number.

Respectfully submitted,
Chuen Khiang WANG et al.

A handwritten signature in black ink, appearing to read "Linda J. Hodge", written over a horizontal line.

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FORM PTO-1449

U.S. Department of Commerce
Patent and Trademark OfficeAtty. Docket No.
P26634Application No.
10/598,514INFORMATION DISCLOSURE STATEMENT
BY APPLICANT

(Use several sheets if necessary)

Applicant
Chuen Kiang WANG et al.Filing Date
March 3, 2005Group
Unknown

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
		6 1 0 7 1 0 9	08/22/00	AKRAM et al.			
		5 2 2 2 0 1 4	06/22/93	LIN			
	2002	0 0 2 7 2 9 5	03/07/02	KIKUMA et al.			
		6 7 8 1 2 4 1	08/24/04	NISHIMURA et al.			
	2002	0 1 4 9 0 9 7	10/17/02	LEE et al.			
	2003	0 1 9 7 2 8 4	10/23/03	KHIANG et al.			
	2004	0 1 5 9 9 5 4	08/19/04	HETZEL et al.			

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
		1 3 5 5 3 5 2	10/22/03	E.P.O.			
	2004	0 8 8 7 2 7	10/14/04	W.I.P.O			

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER

DATE CONSIDERED

*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.